

INTERNATIONAL STANDARD

NORME INTERNATIONALE

Test methods for electrical materials, printed boards and other interconnection structures and assemblies –

**Part 2-807: Test methods for materials for interconnection structures –
Decomposition temperature (T_d) using TGA**

Méthodes d'essai pour les matériaux électriques, les cartes imprimées et autres structures d'interconnexion et ensembles –

Partie 2-807: Méthodes d'essai des matériaux pour structures d'interconnexion – Température de décomposition (T_d) par analyse thermogravimétrique



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INTERNATIONAL ELECTROTECHNICAL COMMISSION

**TEST METHODS FOR ELECTRICAL MATERIALS, PRINTED BOARDS
AND OTHER INTERCONNECTION STRUCTURES AND ASSEMBLIES –****Part 2-807: Test methods for materials for interconnection structures –
Decomposition temperature (T_d) using TGA**

FOREWORD

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IEC 61189-2-807 has been prepared by IEC technical committee 91: Electronics assembly technology. It is an International Standard.

The text of this International Standard is based on the following documents:

Draft	Report on voting
91/1697/CDV	91/1738/RVC

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this International Standard is English.

This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available at www.iec.ch/members_experts/refdocs. The main document types developed by IEC are described in greater detail at www.iec.ch/standardsdev/publications.

A list of all parts in the IEC 61189 series, published under the general title *Test methods for electrical materials, printed boards and other interconnection structures and assemblies*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under webstore.iec.ch in the data related to the specific document. At this date, the document will be

- reconfirmed,
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- replaced by a revised edition, or
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TEST METHODS FOR ELECTRICAL MATERIALS, PRINTED BOARDS AND OTHER INTERCONNECTION STRUCTURES AND ASSEMBLIES –

Part 2-807: Test methods for materials for interconnection structures – Decomposition temperature (T_d) using TGA

1 Scope

This part of IEC 61189 specifies a test method to determine the decomposition temperature (T_d) of base laminate materials using thermogravimetric analysis (TGA).

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60194-2, *Printed boards design, manufacture and assembly – Vocabulary – Part 2: Common usage in electronic technologies as well as printed board and electronic assembly technologies*

ISO 11358-1, *Plastics – Thermogravimetry (TG) of polymers – Part 1: General principles*

3 Terms and definitions

For the purposes of this document, the terms and definitions given in IEC 60194-2 apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- IEC Electropedia available at <http://www.electropedia.org/>
- ISO Online browsing platform available at <https://www.iso.org/obp>

4 Test specimens

4.1 Specimens shall be an unclad laminate material or laminate material where the copper has been completely removed.

4.2 The typical weight of the sample is 10 mg to 30 mg. Samples shall be cut to a specified size which is suitable for the sample pan using appropriate procedures and equipment. All edges of the sample shall be finished such that it is smooth and burr-free to allow the sample to rest completely flat on the sample pan. This can be achieved by sanding or equivalent. Use care to minimize the introduction of mechanical stress, and that any sanding medium does not become embedded into the sample.

NOTE 1 Samples of the same mass but with a smaller surface area are likely to lose mass at a slower rate.

NOTE 2 It is recognized that different resin content of the samples is likely to yield different T_d results.